

524.

标题: Electric instability in multibarrier heterostructures: Features of the RF impedance

作者: Gergel', VA (Gergel', V. A.); Verkhovtseva, AV (Verkhovtseva, A. V.); Gorshkova, NM (Gorshkova, N. M.); Yakupov, MN (Yakupov, M. N.)

来源出版物: JOURNAL OF COMMUNICATIONS TECHNOLOGY AND ELECTRONICS 卷: 57 期: 4 页: 441-444 DOI: 10.1134/S1064226912040080 出版年: APR 2012

在 Web of Science 中的被引频次: 0

被引频次合计: 0

引用的参考文献数: 4

摘要: By mathematical simulation of the electric conduction in multibarrier heterostructures, static voltage-current characteristics (VCCs) whose S-shape is indicative of the corresponding electric instability have been obtained. In order to analyze the dynamic parameters of this instability, an analytical model of the instability under investigation has been constructed with the use of the known approximations of semiconductor physics. The static version of the analytical model also provides an S-shaped VCC that is close to the corresponding results of the numerical simulation. With this closeness considered as a confirmation of the validity of the developed analytical model, the small-signal version of this model is generalized to the case of a harmonic electrical disturbance. A clear physical interpretation of the instability under consideration in terms of a positive feedback in a unit cell of the multibarrier heterostructures under study is proposed. The resulting formula for the frequency dependence of the small-signal impedance shows that the dynamic impedance is negative up to terahertz frequencies.

入藏号: WOS:000302901200017

语种: English

文献类型: Article

地址: [Gergel', V. A.; Verkhovtseva, A. V.; Gorshkova, N. M.; Yakupov, M. N.] Russian Acad Sci, Kotelnikov Inst Radio Engn & Elect, Moscow 125009, Russia

通讯作者地址: Gergel', VA (通讯作者), Russian Acad Sci, Kotelnikov Inst Radio Engn & Elect, Ul Mokhovaya 11, Korp 7, Moscow 125009, Russia

出版商: MAIK NAUKA/INTERPERIODICA/SPRINGER

出版商地址: 233 SPRING ST, NEW YORK, NY 10013-1578 USA

Web of Science 分类: Engineering, Electrical & Electronic; Telecommunications

学科类别: Engineering; Telecommunications

IDS 号: 927IP

ISSN: 1064-2269

29 字符的来源出版物名称缩写: J COMMUN TECHNOL EL+

ISO 来源出版物缩写: J. Commun. Technol. Electron.

来源出版物页码计数: 4